

Parallel NOR Flash Embedded Memory

M29W640FT, M29W640FB

Features

- Supply voltage
 - $-V_{CC} = 2.7-3.6V$ (program, erase, read)
 - $V_{pp} = 12V$ for fast program (optional)
- Asynchronous random/page read
 - Page width: 4 words
 - Page access: 25ns
 - Random access: 60ns, 70ns
- · Program time
 - 10µs per byte/word TYP
 - 4 words/8 bytes program
- · Memory organization
 - 135 memory blocks
 - 1 boot block and 7 parameter blocks, 8KB each (top or bottom)
 - 127 main blocks, 64KB each
- · Program/erase controller
 - Embedded byte/word program algorithms
- Program/erase suspend and resume
 - Read from any block during a PROGRAM SUS-PEND operation
 - Read or program another block during an ERASE SUSPEND operation

- UNLOCK BYPASS PROGRAM command
 - Faster production/batch programming
- V_{PP}/WP# pin for fast program and write protect
- · Temporary block unprotection mode
- Common Flash interface
 - 64-bit security code
- · Extended memory block
 - Extra block used as security block or to store additional information
- Low power consumption
 - Standby and automatic standby
- 100,000 PROGRAM/ERASE cycles per block
- Electronic signature
 - Manufacturer code: 0020h
 - Device code M29W640FT: 22EDh
 - Device code M29W640FB: 22FDh
- · RoHS-compliant packages
 - 48-pin TSOP (N) 12mm x 20mm
 - 48-ball TFBGA (ZA) 6mm x 8mm



Part Numbering Information

Available with extended memory block prelocked by Micron. Devices are shipped from the factory with memory content bits erased to 1. For available options, such as packages or speed, or for further information, contact your Micron sales representative. Part numbers can be verified at www.micron.com. Feature and specification comparison by device type is available at www.micron.com/products. Contact the factory for devices not found.

Table 1: Part Number Information

| Part Number Category | Category Details | |
|-------------------------|---|--|
| Device Type | M29 = Parallel Flash memory | |
| Operating Voltage | $W = V_{CC} = 2.7 \text{ to } 3.6V$ | |
| Device Function | 640F = 64Mb (x8/x16) boot block | |
| Array Matrix | T = Top boot | |
| | B = Bottom boot | |
| Speed | 60 = 60ns | |
| | 70 = 70ns | |
| Package | N = 48-pin TSOP: 12mm x 20mm | |
| | ZA = 48-ball TFBGA, 6mm x 8mm, 0.80mm pitch | |
| Temperature Range | 6 = -40°C to 85°C | |
| Shipping Options | E = RoHS-compliant package, standard packing | |
| | F = RoHS-compliant package, tape and reel packing | |



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64Mb: 3V Embedded Parallel NOR Flash General Description

General Description

The M29W640F is a 64Mb (8Mb x8 or 4Mb x16) nonvolatile memory that can be read, erased, and reprogrammed. These operations can be performed using a single low voltage (2.7–3.6V) supply. On power-up, the memory defaults to read mode.

The memory is divided into blocks that can be erased independently so that valid data can be preserved while old data is erased. Blocks can be protected in units of 256KB (typically, groups of four 64KB blocks), to prevent accidental PROGRAM or ERASE commands from modifying the memory. PROGRAM and ERASE commands are written to the command interface. An on-chip program/erase controller simplifies the process of programming or erasing the memory by taking care of all of the special operations that are required to update the memory contents. The end of a PROGRAM or ERASE operation can be detected and any error conditions identified. The command set required to control the memory is consistent with JEDEC standards.

The device features an asymmetrical blocked architecture. The device has an array of 135 blocks: 8 parameters blocks of 8KB each (or 4 K words each) and 127 main blocks of 64KB each (or 32K words each)

M29W640FT contains the parameter blocks at the top of the memory address space. The M29W640FB contains the parameter blocks starting from the bottom.

The M29W640F has an extra block, the extended block, of 128 words in x16 mode, or of 256 bytes in x8 mode, that can be accessed using a dedicated command. The extended block can be protected. It is useful for storing security information. However, the protection is not reversible. Once protected, the protection cannot be undone.

CE#, OE#, and WE# signals control the bus operation of the memory. They enable simple connection to most microprocessors, often without additional logic.

 V_{PP}/WP enables faster programming of the device, enabling multiple word/byte programming. If this signal is held at V_{SS} , the boot block and its adjacent parameter block are protected from PROGRAM and ERASE operations.

The device supports asynchronous random read and page read from all blocks of the memory array.

In order to meet environmental requirements, Micron offers the M29W640FT and the M29W640FB in RoHS packages (lead-free). The category of second-level interconnect is marked on the package and on the inner box label, in compliance with JEDEC-Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label.

The memory is delivered with all the bits erased (set to 1).



Figure 1: Logic Diagram

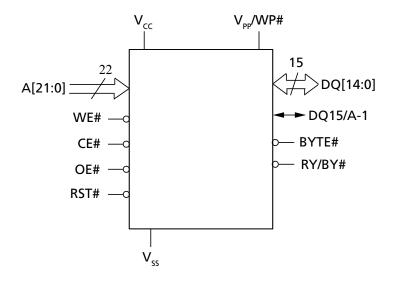


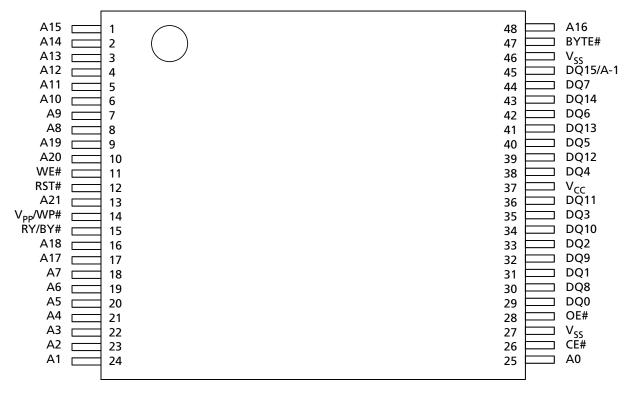
Table 2: Signal Names

| Name | Туре | Description |
|----------------------|----------------|--|
| A[21:0] | Input | Address inputs |
| CE# | Input | Chip enable |
| OE# | Input | Output enable |
| WE# | Input | Write enable |
| RST# | Input | Reset/block temporary unprotect |
| RY/BY# | Input | Ready/busy |
| BYTE# | Input | Byte/word organization select |
| DQ[7:0] | I/O | Data input/outputs |
| DQ[14:8] | I/O | Data input/outputs |
| DQ15A-1 (or DQ15) | I/O | Data input/output or address input (or data I/O) |
| V _{CC} | Supply voltage | Supply voltage |
| V _{PP} /WP# | Supply voltage | Supply voltage for FAST PROGRAM (optional) or WRITE PROTECT operations |
| V _{SS} | - | Ground |
| NC | _ | Not connected internally |



Signal Assignments

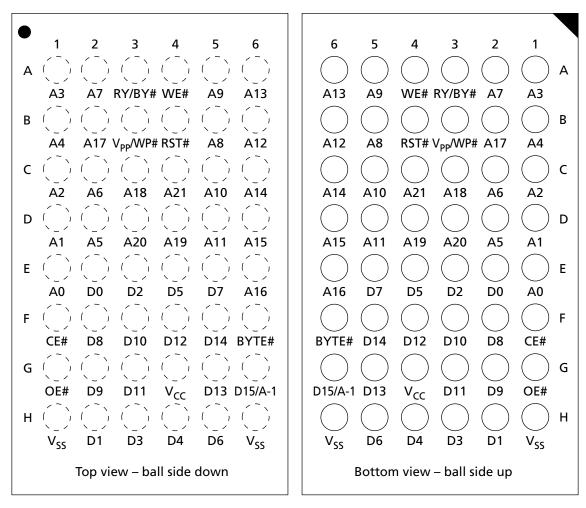
Figure 2: 48-Pin TSOP Pinout



Note: 1. RFU = reserved for future use.



Figure 3: 48-Ball TFBGA Ballout



Note: 1. RFU = reserved for future use.



Signal Descriptions

The signal description table below is a comprehensive list of signals for this device family. All signals listed may not be supported on this device. See Signal Assignments for information specific to this device.

Table 3: Signal Descriptions

| Name | Туре | Description | |
|----------------------|-------|--|--|
| A[MAX:0] | Input | Address: Select the cells in the memory array to access during bus READ operations. During bus WRITE operations they control the commands sent to the command interface of the program/erase controller. | |
| CE# | Input | Chip enable: Activates the memory, allowing bus READ and bus WRTE operations to be performed. When CE# is HIGH, all other pins are ignored. | |
| OE# | Input | Output enable: Controls the bus READ operation of the memory. | |
| WE# | Input | Write enable: Controls the bus write operation of the memory's command interface. | |
| V _{PP} /WP# | Input | $V_{PP}/WP\#$: Provides two functions: V_{PP} enables the memory to use an external high-voltage power supply to reduce the time required for UNLOCK BYPASS PROGRAM operations. WP# performs hardware protection by protection the last block at the end of the addressable area (M29W640GH) or the first block at the beginning of the addressable area (M29W640GT) and the first two boot blocks at the beginning of the addressable area (M29W640GB). | |
| | | V_{PP} /WP# may be left floating or unconnected (see DC Characteristics). When V_{PP} /WP# is LOW, the last or first block in the M29W640GH and M29W640GL, respectively, and the last or first two blocks in the M29W640GT and M29W640GB, respectively, are protected. PROGRAM and ERASE operations in this block are ignored while V_{PP} /WP# is LOW, even when RST# is at V_{ID} . | |
| | | When V_{PP} /WP# is HIGH, V_{IH} , the device reverts to the previous protection status of the outermost blocks. PROGRAM and ERASE operations can now modify the data in the outermost blocks unless the block is protected using block protection. | |
| | | Applying 12V to V_{PP} /WP# will temporarily unprotect any block previously protected (including the outermost blocks) using a high-voltage block protection technique (in-system or programmer technique). (See Hardware Protection for details. When V_{PP} /WP# is raised to V_{PP} , the device automatically enters the unlock bypass mode. When V_{PP} /WP# returns to V_{IH} or V_{IL} , normal operation resumes. During UNLOCK BYPASS PROGRAM operations, the device draws I_{PP} from the pin to supply the programming circuits. (See UNLOCK BYPASS Command.) The transitions from V_{IH} to V_{PP} and from V_{PP} to V_{IH} must be slower than ${}^{t}VHVPP$ (See the Accelerated Program Timing waveforms). | |
| | | Never raise V_{PP} /WP# to V_{PP} from any mode except read mode; otherwise, the device may be left in an indeterminate state. | |
| | | A $0.1\mu F$ capacitor should be connected between $V_{PP}/WP\#$ and the V_{SS} ground pin to decouple the current surges from the power supply. The PCB track widths must be sufficient to carry the currents required during an UNLOCK BYPASS PROGRAM operation, I_{PP} . | |



Table 3: Signal Descriptions (Continued)

| Name | Туре | Description | | |
|-----------------|--------|---|--|--|
| RST# | Input | Reset/Block temporary unprotect: Applies a hardware reset to the memory or temporarily unprotect all blocks that have been protected. | | |
| | | Note that if V_{PP} /WP is at V_{IL} , then the last and the first block in the M29W640GH and M29W640GL, respectively, and the last two and first two blocks in the M29W640GT and M29W640GB, respectively, will remain protected, even if RST# is at V_{ID} . | | |
| | | A hardware reset is achieved by holding RST# LOW for at least ^t PLPX. After RST# goes HIGH, the memory will be ready for bus READ and bus WRITE operations after ^t PHEL or ^t RHEL, whichever occurs last. (See Reset Characteristics for more details.) | | |
| | | Holding RST# at V_{ID} will temporarily unprotect the protected blocks in the memory. PRO-GRAM and ERASE operations on all blocks will be possible. The transition from V_{IH} to V_{ID} must be slower than t PHPHH. | | |
| DQ15/A-1 | I/O | Data I/O or address input: When HIGH, behaves as a data I/o pin (as DQ8–DQ14). When LOW, behaves as an address pin; DQ15A–1 LOW will select the LSB of the addressed word; DQ15A–1 HIGH will select the MSB. Throughout the text, consider references to the data I/O to include this pin when BYTE# is HIGH and references to the address inputs to include this pin when BYTE# is LOW, except when stated explicitly otherwise. | | |
| DQ[14:8] | I/O | Data I/O: Outputs the data stored at the selected address during a bus READ operation when BYTE# is HIGH. When BYTE# is LOW, these pins are not used and are High-Z. During bus WRITE operations, the command register does not use these bits. When reading the status register these bits should be ignored. | | |
| DQ[7:0] | I/O | Data I/O: Outputs the data stored at the selected address during a bus READ operation. During bus WRITE operations, they represent the commands sent to the command interface of the program/erase controller. | | |
| RY/BY# | Output | Ready busy: Open-drain output that identifies when the device is performing a PROGRAM or ERASE operation. During PROGRAM or ERASE operations, RY/BY# is LOW, and is High-Z during read mode, auto select mode, and erase suspend mode. | | |
| | | After a hardware reset, bus READ and WRITE operations cannot begin until RY/BY# becomes High-Z. (See Reset Characteristics for more details.) | | |
| | | The use of an open-drain output enables RY/BY# pins from several devices to be connected to a single pull-up resistor. A LOW will then indicate that one, or more, of the devices is busy. | | |
| BYTE# | Input | BYTE#/Word organization select: Switches between the x8 and x16 bus modes of the device. When LOW, the device is in x8 mode; when HIGH, it is in x16 mode. | | |
| V _{CC} | Supply | Supply voltage: Provides the power supply for all operations (READ, PROGRAM, and ERASE). | | |
| | | The command interface is disabled when the V_{CC} supply voltage is less than the lockout voltage, V_{LKO} . This prevents bus WRITE operations from accidentally damaging the data during power-up, power-down, and power surges. If the program/erase controller is programming or erasing during this time, then the operation aborts and the memory contents being altered will be invalid. | | |
| | | A 0.1 μ F capacitor should be connected between the V _{CC} supply voltage pin and the V _{SS} ground pin to decouple the current surges from the power supply. The PCB track widths must be sufficient to carry the currents required during PROGRAM and ERASE operations, I _{CC3} . | | |

Table 3: Signal Descriptions (Continued)

| Name | Туре | Description |
|----------|--------|---|
| V_{SS} | Supply | Ground: Reference for all voltage measurements. The device features two V _{SS} pins which |
| | | must be both connected to the system ground. |
| RFU | _ | Reserved for future use: RFUs should be not connected. |

Table 4: Hardware Protection

| V _{PP} /WP# | RST# | Function | |
|------------------------------------|------------------------------------|--|--|
| V _{IL} | V _{IH} | Two outermost parameter blocks protected from PROGRAM or ERAS operations | |
| | V _{ID} | All blocks unprotected temporarily except the two outermost blocks | |
| V _{IH} or V _{ID} | V _{ID} | All blocks unprotected temporarily | |
| V _{PPH} | V _{IH} or V _{ID} | All blocks unprotected temporarily | |



Memory Organization

Memory Configuration

The main memory array is divided into 64KB blocks.

The blocks in the memory are asymmetrically arranged. The first or last 64KB of memory has been divided into eight 8KB parameter blocks.

x8 Memory Map - 64Mb Density

Table 5: x8 Top Boot - Blocks [134:0]

| | | Addres | | |
|-------|------------|-----------|-----------|-------|
| Block | Block Size | Start | End | Notes |
| 134 | 8KB | 007F E000 | 007F FFFF | 1 |
| 133 | 8KB | 007F C000 | 007F DFFF | |
| 132 | 8KB | 007F A000 | 007F BFFF | |
| 131 | 8KB | 007F 8000 | 007F 9FFF | |
| 130 | 8KB | 007F 6000 | 007F 7FFF | |
| 129 | 8KB | 007F 4000 | 007F 5FFF | |
| 128 | 8KB | 007F 2000 | 007F 3FFF | |
| 127 | 8KB | 007F 0000 | 007F 1FFF | |
| 126 | 64KB | 007E 0000 | 007E FFFF | |
| i i | i. | <u>:</u> | : | |
| 2 | 64KB | 0002 0000 | 0002 FFFF | |
| 1 | 64KB | 0001 0000 | 0001 FFFF | |
| 0 | 64KB | 0000 0000 | 0000 FFFF | |

Note: 1. Used as the extended block addresses when the device is in extended block mode.

Table 6: x8 Bottom Boot - Blocks [134:0]

| | | Address | | |
|-------|------------|-----------|-----------|-------|
| Block | Block Size | Start | End | Notes |
| 134 | 64KB | 007F 0000 | 007F FFFF | |
| 133 | 64KB | 007E 0000 | 007E FFFF | |
| 132 | 64KB | 007D 0000 | 007D FFFF | |
| i i | : | : | i. | |
| 8 | 64KB | 0001 0000 | 0001 FFFF | |



Table 6: x8 Bottom Boot - Blocks [134:0] (Continued)

| | | Address | s Range | |
|-------|------------|-----------|-----------|-------|
| Block | Block Size | Start | End | Notes |
| 7 | 8KB | 0000 E000 | 0000 FFFF | 1 |
| 6 | 8KB | 0000 C000 | 0000 DFFF | |
| 5 | 8KB | 0000 A000 | 0000 BFFF | |
| 4 | 8KB | 0000 8000 | 0000 9FFF | |
| 3 | 8KB | 0000 6000 | 0000 7FFF | |
| 2 | 8KB | 0000 4000 | 0000 5FFF | |
| 1 | 8KB | 0000 2000 | 0000 3FFF | |
| 0 | 8KB | 0000 0000 | 0000 1FFF | |

Note: 1. Used as the extended block addresses when the device is in extended block mode.



x16 Memory Map - 64Mb Density

Table 7: x16 Top Boot - Blocks [134:0]

| | | Addres | s Range | |
|-------|------------|-----------|-----------|-------|
| Block | Block Size | Start | End | Notes |
| 134 | 8KW | 003F F000 | 003F FFFF | 1 |
| 133 | 8KW | 003F E000 | 003F EFFF | |
| 132 | 8KW | 003F D000 | 003F DFFF | |
| 131 | 8KW | 003F C000 | 003F CFFF | |
| 130 | 8KW | 003F B000 | 003F BFFF | |
| 129 | 8KW | 003F A000 | 003F AFFF | |
| 128 | 8KW | 003F 9000 | 003F 9FFF | |
| 127 | 8KW | 003F 8000 | 003F 8FFF | |
| 126 | 32KW | 003F 0000 | 003F 7FFF | |
| : | : | i i | : | |
| 2 | 32KW | 0001 0000 | 0001 7FFF | |
| 1 | 32KW | 0000 8000 | 0000 FFFF | |
| 0 | 32KW | 0000 0000 | 0000 7FFF | |

Note: 1. Used as the extended block addresses when the device is in extended block mode.

Table 8: x16 Bottom Boot - Blocks [134:0]

| | | Addres | ss Range | |
|-------|------------|-----------|-----------|-------|
| Block | Block Size | Start | End | Notes |
| 134 | 32KW | 003F 8000 | 003F FFFF | |
| 133 | 32KW | 003F 0000 | 003F 7FFF | |
| 132 | 32KW | 003E 8000 | 003E FFFF | |
| ÷ | : | i i | i i | |
| 8 | 32KW | 0000 8000 | 000F FFFF | |
| 7 | 8KW | 0000 7000 | 0007 7FFF | 1 |
| 6 | 8KW | 0000 6000 | 0006 6FFF | |
| 5 | 8KW | 0000 5000 | 0005 5FFF | |
| 4 | 8KW | 0000 4000 | 0004 4FFF | |
| 3 | 8KW | 0000 3000 | 0003 3FFF | |
| 2 | 8KW | 0000 2000 | 0002 2FFF | |
| 1 | 8KW | 0000 1000 | 0001 1FFF | |
| 0 | 8KW | 0000 0000 | 0000 7FFF | |

Note: 1. Used as the extended block addresses when the device is in extended block mode.



Bus Operations

Table 9: Bus Operations

Notes 1 and 2 apply to entire table

| | | | | 8- | Bit Mode | 16-Bit N | /lode | |
|-------------------|-----|-----|-----|-----------------------|----------|-------------------------|-----------------|-------------------------|
| Operation | CE# | OE# | WE# | A[MAX:0], DQ15/A-1 | DQ[14:8] | DQ[7:0] | A[MAX:0] | DQ15/A-1, DQ[14:0] |
| READ | L | L | Н | Cell address | High-Z | Data output | Cell address | Data output |
| WRITE | L | Н | L | Command address | High-Z | Data input ⁴ | Command address | Data input ⁴ |
| STANDBY | Н | Х | Х | Х | High-Z | High-Z | Х | High-Z |
| OUTPUT DISABLE | Х | Н | Н | Х | High-Z | High-Z | Х | High-Z |

Notes

- 1. Typical glitches of less than 5ns on CE# and WE# are ignored by the device and do not affect bus operations.
- 2. $H = Logic level HIGH (V_{IH})$; $L = Logic level LOW (V_{IL})$; X = HIGH or LOW.
- 3. If WP# = LOW, the highest/lowest block remains protected, depending on the line item.
- 4. Data input is required when issuing a command sequence or performing data polling or block protection.

Read

Bus READ operations read from the memory cells, registers, or CFI space. A valid READ operation requires setting the appropriate address on the address inputs, taking CE# and OE# LOW and holding WE# HIGH. Data I/O signals output the value.

Write

Bus WRITE operations write to the command interface. A valid WRITE operation requires setting the appropriate address on the address inputs. These are latched by the command interface on the falling edge of CE# or WE#, whichever occurs last. Values on data I/O signals are latched by the command interface on the rising edge of CE# or WE#, whichever occurs first. OE# must remain HIGH during the entire operation.

Standby and Automatic Standby

When the device is in read mode, driving CE# HIGH places the device in standby mode and drives data I/Os to High-Z. Supply current is reduced to standby (I_{CC2}), by holding CE# within V_{CC} ±0.2V.

During PROGRAM or ERASE operations, the device continues to use the program/erase supply current (I_{CC3}) until the operation completes.

Automatic standby enables low power consumption during read mode. When CMOS levels ($V_{CC} \pm 0.2\,V$) drive the bus, and following a READ operation and a period of inactivity specified in DC Characteristics, the memory enters automatic standby as internal supply current is reduced to I_{CC2} . Data I/O signals still output data if a READ operation is in progress.

Output Disable

Data I/Os are High-Z when OE# is HIGH.



Status Register

Bus READ operations from any address always read the status register during PRO-GRAM and ERASE operations. It is also read during ERASE SUSPEND operations when an address within a block being erased is accessed. The bits in the status register are summarized in the Status Register Bits table.

Data Polling Bit (DQ7)

The data polling bit can be used to identify whether the program/erase controller has successfully completed its operation or if it has responded to an ERASE SUSPEND operation. The data polling bit is output on DQ7 when the status register is read.

During PROGRAM operations, the data polling bit outputs the complement of the bit being programmed to DQ7. After successful completion of the PROGRAM operation, the memory returns to read mode, and bus READ operations from the address just programmed output DQ7, not its complement.

During ERASE operations, the data polling bit outputs 0, the complement of the erased state of DQ7. After successful completion of the ERASE operation, the memory returns to read mode.

In erase suspend mode, the data polling bit will output a 1 during a bus READ operation within a block being erased. The data polling bit will change from a 0 to a 1 when the program/erase controller has suspended the ERASE operation. The Data Polling Flow-chart gives an example of how to use the data polling bit. A valid address is the address being programmed or an address within the block being erased.

Toggle Bit (DQ6)

The toggle bit can be used to identify whether the program/erase controller has successfully completed its operation or if it has responded to an ERASE SUSPEND command. The toggle bit is output on DQ6 when the status register is read.

During PROGRAM and ERASE operations, the toggle bit changes from 0 to 1 to 0, etc., with successive bus READ operations at any address. After successful completion of the operation, the memory returns to read mode.

During erase suspend mode, the toggle bit will output when addressing a cell within a block being erased. The toggle bit will stop toggling when the program/erase controller has suspended the ERASE operation.

If any attempt is made to erase a protected block, the operation is aborted, no error is signaled, and DQ6 toggles for approximately $100\mu s$. If any attempt is made to program a protected block or a suspended block, the operation is aborted, no error is signaled, and DQ6 toggles for approximately $1\mu s$. The Data Toggle Flowchart gives an example of how to use the data toggle bit.

Error Bit (DQ5)

The error bit can be used to identify errors detected by the program/erase controller. The error bit is set to 1 when a PROGRAM, BLOCK ERASE, or CHIP ERASE operation fails to write the correct data to the memory. If the error bit is set, a READ/RESET command must be issued before other commands are issued. The error bit is output on DQ5 when the status register is read.

64Mb: 3V Embedded Parallel NOR Flash Status Register

Note that the PROGRAM command cannot change a bit set to 0 back to 1, and attempting to do so will set DQ5 to 1. A bus READ operation to that address will show the bit is still 0. One of the ERASE commands must be used to set all the bits in a block or in the whole memory from 0 to 1.

Erase Timer Bit (DQ3)

The erase timer bit can be used to identify the start of program/erase controller operation during a BLOCK ERASE command. When the program/erase controller starts erasing, the erase timer bit is set to 1. Before the program/erase controller starts, the erase timer bit is set to 0, and additional blocks to be erased may be written to the command interface. The erase timer bit is output on DQ3 when the status register is read.

Alternative Toggle Bit (DQ2)

The alternative toggle bit can be used to monitor the program/erase controller during ERASE operations. It is output on DQ2 when the status register is read.

During CHIP ERASE and BLOCK ERASE operations, the toggle bit changes from 0 to 1 to 0, etc., with successive bus READ operations from addresses within the blocks being erased. A protected block is treated the same as a block not being erased. After the operation completes, the memory returns to read mode.

During an ERASE SUSPEND operation, the alternative toggle bit changes from 0 to 1 to 0, etc., with successive bus READ operations from addresses within the blocks being erased. Bus READ operations to addresses within blocks not being erased will output the memory cell data as if in read mode.

After an ERASE operation that causes the error bit to be set, the alternative toggle bit can be used to identify which block or blocks have caused the error. The alternative toggle bit changes from 0 to 1 to 0, etc., with successive bus READ operations from addresses within blocks that have not erased correctly. The alternative toggle bit does not change if the addressed block has erased correctly.

Table 10: Status Register Bits

| Operation | Address | DQ7 | DQ6 | DQ5 | DQ3 | DQ2 | RY/BY# | |
|---------------------------------|---------------------------------------|------|-----------|-----|-----|-----------|--------|--|
| PROGRAM | Any address | DQ7# | Toggle | 0 | _ | _ | 0 | |
| PROGRAM DURING ERASE SUSPEND | Any address | DQ7# | Toggle | 0 | _ | - | 0 | |
| PROGRAM ERROR | Any address | DQ7# | Toggle | 1 | _ | _ | Hi-Z | |
| CHIP ERASE | Any address | 0 | Toggle | 0 | 1 | Toggle | 0 | |
| BLOCK ERASE BEFORE | Erasing block | 0 | Toggle | 0 | 0 | Toggle | 0 | |
| TIMEOUT | Non-erasing block | 0 | Toggle | 0 | 0 | No Toggle | 0 | |
| BLOCK ERASE | Erasing block | 0 | Toggle | 0 | 1 | Toggle | 0 | |
| | Non-erasing block | 0 | Toggle | 0 | 1 | No Toggle | 0 | |
| ERASE SUSPEND | Erasing block | 1 | No Toggle | 0 | _ | Toggle | Hi-Z | |
| | Non-erasing block Data read as normal | | | | | | | |



Table 10: Status Register Bits (Continued)

| Operation | Address | DQ7 | DQ6 | DQ5 | DQ3 | DQ2 | RY/BY# |
|-------------|----------------------|-----|--------|-----|-----|-----------|--------|
| ERASE ERROR | Good block address | 0 | Toggle | 1 | 1 | No Toggle | Hi-Z |
| | Faulty block address | 0 | Toggle | 1 | 1 | Toggle | Hi-Z |

Note: 1. Unspecified data bits should be ignored.

Figure 4: Data Polling Flowchart

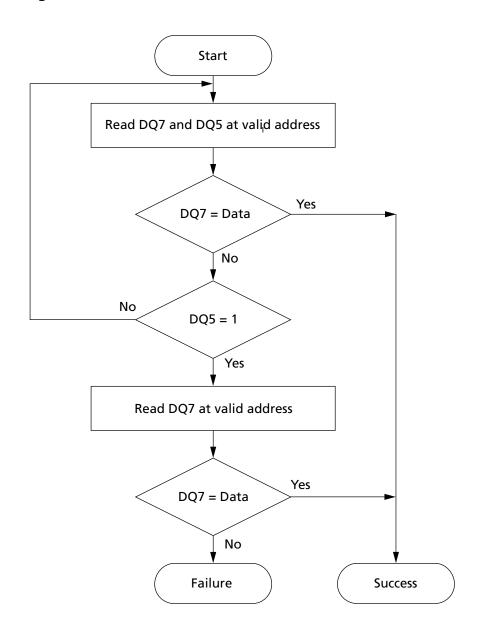
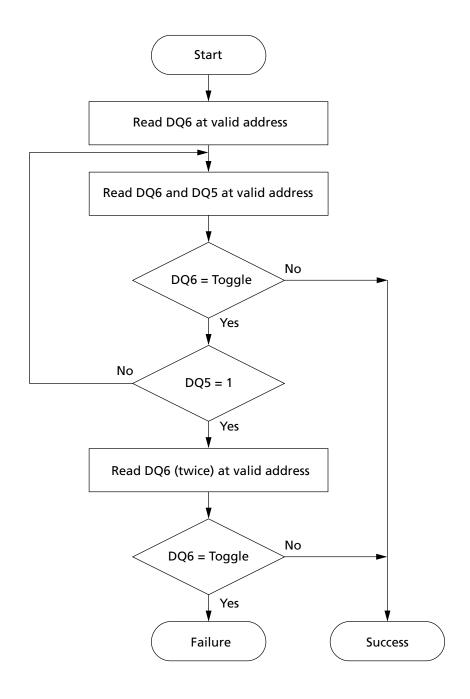




Figure 5: Data Toggle Flowchart





READ Operations

READ/RESET Command

The READ/RESET (F0h) command returns the device to read mode and resets the errors in the status register. One or three bus WRITE operations can be used to issue the READ/RESET command.

To return the device to read mode, this command can be issued between bus WRITE cycles before the start of a PROGRAM or ERASE operation. If the READ/RESET command is issued during the timeout of a BLOCK ERASE operation, the device requires up to 10µs to abort, during which time no valid data can be read.

READ CFI Command

The READ CFI (98h) command puts the device in read CFI mode and is valid only when the device is in read array or auto select mode. One bus WRITE cycle is required to issue the command.

Once in read CFI mode, bus READ operations will output data from the CFI memory area. A READ/RESET command must be issued to return the device to the previous mode (read array or auto select). A second READ/RESET command is required to put the device in read array mode from auto select mode.



AUTO SELECT Operations

AUTO SELECT Command

At power-up or after a hardware reset, the device is in read mode. It can then be put in auto select mode by issuing an AUTO SELECT (90h) command or by applying $V_{\rm ID}$ to A9. Auto select mode enables the following device information to be read:

- Electronic signature, which includes manufacturer and device code information.
- Block protection, which includes the block protection status and extended memory block protection indicator.

Electronic signature or block protection information is read by executing a READ operation with control signals and addresses set.

Auto select mode can be used by the programming equipment to automatically match a device with the application code to be programmed.

Three consecutive bus WRITE operations are required to issue an AUTO SELECT command. The device remains in auto select mode until a READ/RESET or READ CFI command is issued.

The device cannot enter auto select mode when a PROGRAM or ERASE operation is in progress (RY/BY# LOW). However, auto select mode can be entered if the PROGRAM or ERASE operation has been suspended by issuing a PROGRAM SUSPEND or ERASE SUSPEND command.

To enter auto select mode by applying V_{ID} to A9 (see the following tables).

Auto select mode is exited by performing a reset. The device returns to read mode unless it entered auto select mode after an ERASE SUSPEND or PROGRAM SUSPEND command, in which case it returns to erase or program suspend mode.

Table 11: Read Electronic Signature

Note 1 applies to entire table

| | READ Cycle | | | | | | | |
|-------------------------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-------|--|
| | Manufacturer | | Device | Code 2 | Device Code 3 | | Notes | |
| Signal | Code | Device Code 1 | GH/GL | GT/GB | GH/GT | GL/GB | | |
| CE# | L | L | L | L | L | L | | |
| OE# | L | L | L | L | L | L | | |
| WE# | Н | Н | Н | Н | Н | Н | | |
| Address Input, 8-Bit and 16-B | it | | | | <u> </u> | • | | |
| A[MAX:10] | Х | Х | Х | Х | Х | Х | | |
| A9 | V _{ID} | 2 | |
| A8 | Х | Х | | Х | | Х | | |
| A[7:5] | L | L | | L | | L | | |
| A4 | Х | Х | | Х | | Х | | |
| A[3:1] | L | L | | Н | | Н | | |
| A0 | L | Н | | L | | Н | | |
| Address Input, 8-Bit Only | | | | | | | | |



Table 11: Read Electronic Signature (Continued)

Note 1 applies to entire table

| | READ Cycle | | | | | | | | |
|--------------------------|--------------|---------------|--------|--------|--------|--------|-------|--|--|
| | Manufacturer | | Device | Code 2 | Device | Code 3 | Notes | | |
| Signal | Code | Device Code 1 | GH/GL | GT/GB | GH/GT | GL/GB | | | |
| DQ[15]/A-1 | Х | Х | | Х | | Х | | | |
| Data I/O, 8-Bit Only | , | | | | | | | | |
| DQ[14:8] | Х | Х | | Х | | Х | | | |
| DQ[7:0] | 20h | 7Eh | 0Ch | 10h | 01h | 00h | | | |
| Data I/O, 16-Bit Only | • | | | | | | | | |
| DQ[15]/A-1, and DQ[14:0] | 0020h | 227Eh | 220Ch | 2210h | 2201h | 2200h | | | |

- Notes: 1. $H = Logic level HIGH (V_{IH})$; $L = Logic level LOW (V_{IL})$; X = HIGH or LOW.
 - 2. When using the AUTO SELECT command to enter auto select mode, applying V_{ID} to A9 is not required. A9 can be either V_{IL} or V_{IH} .

Table 12: Block Protection

Note 1 applies to entire table

| | | | | | Address Input | | | | | | | | Data I/O | |
|-------------------------------|-----------------|-----------------|-----|--------|---------------|----------|-----|--------------------------------|-----------------|-----------|--------|----|----------|------------------------------------|
| Operation | CE# | OE# | WE# | A[MAX] | A15 | A[14:13] | A12 | A[11:10], A[8:7], A[5:4] | А9 | A6 | A[3:2] | A1 | Α0 | DQ15/A-1, DQ[14:0] |
| BLOCK PROTECT (Group) | L | V _{ID} | LP | | Block | address | | Х | V _{ID} | | Х | | | Х |
| CHIP UNPROTECT | V _{ID} | V _{ID} | LP | Х | Н | Х | Н | Х | V _{ID} | | Х | | | Х |
| VERIFY BLOCK PROTECTION | L | L | Н | | Block | address | | Х | V _{ID} | L | L | Н | L | Pass = xx01h Retry= xx00h |
| VERIFY BLOCK UNPROTECT | L | L | Н | | Block | address | | Х | V _{ID} | Н | L | Н | L | Retry = xx01h Pass= xx00h |

Note: 1. $H = Logic level HIGH (V_{IH})$; $L = Logic level LOW (V_{IL})$; LP = L pulse; X = HIGH or LOW.



Command Interface

All bus WRITE operations to the memory are interpreted by the command interface. Commands consist of one or more sequential bus WRITE operations. Failure to observe a valid sequence of bus WRITE operations will result in the memory returning to read mode. The long command sequences are imposed to maximize data security.

The address used for the commands changes, depending on whether the memory is in 16-bit or 8-bit mode. See the x8 and x16 command tables, depending on the configuration that is being used, for a summary of the commands.

READ/RESET Command

The READ/RESET command returns the memory to read mode. It also resets the errors in the status register. Either one or three bus WRITE operations can be used to issue the READ/RESET command.

The READ/RESET command can be issued, between bus WRITE cycles before the start of a PROGRAM or ERASE operation, to return the device to read mode. If the READ/RESET command is issued during the timeout of a BLOCK ERASE operation, then the device will take up to 10µs to abort. During the abort period, no valid data can be read from the device. The READ/RESET command will not abort an ERASE operation when issued while in erase suspend.

AUTO SELECT Command

The AUTO SELECT command is used to read the manufacturer code, the device code, the block protection status, and the extended memory block verify code. Three consecutive bus WRITE operations are required to issue the AUTO SELECT command. After the AUTO SELECT command is issued, the memory remains in auto select mode until a READ/RESET command is issued. READ CFI QUERY and READ/RESET commands are accepted in auto select mode; all other commands are ignored.

In auto select mode, the manufacturer code and the device code can be read by using a bus READ operation with addresses and control signals set, as shown Bus Operations, except for A9 (which is "Don't Care").

The block protection status of each block can be read using a bus READ operation with addresses and control signals set, as shown in Bus Operations, except for A9 (which is "Don't Care"). If the addressed block is protected, then 01h is output on DQ0–DQ7; otherwise, 00h is output (in 8-bit mode).

The protection status of the extended memory block, or extended memory block verify code, can be read using a bus READ operation with addresses and control signals, except for A9 (which is "Don't Care"). If the extended block is "factory-locked." then 80h is output on DQ0–DQ7; otherwise, 00h is output (8-bit mode).

READ CFI QUERY Command

The READ CFI QUERY command is used to read data from the CFI. This command is valid when the device is in the read array mode, or when the device is in auto select mode.

One bus WRITE cycle is required to issue the READ CFI QUERY command. After the command is issued, subsequent bus READ operations read from the CFI.



The READ/RESET command must be issued to return the device to the previous mode (the read array mode or auto select mode). A second READ/RESET command would be needed if the device is to be put in the read array mode from auto selected mode.

PROGRAM Command

The PROGRAM command can be used to program a value to one address in the memory array at a time. The command requires four bus WRITE operations; the final WRITE operation latches the address and data, and starts the program/erase controller.

Programming can be suspended and then resumed by issuing a PROGRAM SUSPEND command and a PROGRAM RESUME command, respectively.

If the address falls in a protected block, then the PROGRAM command is ignored, the data remains unchanged. The status register is never read and no error condition is given

During a PROGRAM operation, the memory will ignore all commands. It is not possible to issue any command to abort or pause the operation. Bus READ operations during the PROGRAM operation will output the status register on the data I/Os. (See Status Register for more details.)

After the PROGRAM operation has completed, the memory will return to the read mode, unless an error has occurred. When an error occurs, the memory will continue to output the status register. A READ/RESET command must be issued to reset the error condition and return to read mode.

Note that the PROGRAM command cannot change a bit set to 0 back to 1. One of the ERASE commands must be used to set all the bits in a block or in the whole memory from 0 to 1. (Refer to Program/Erase Characteristics.)

PROGRAM SUSPEND Command

The PROGRAM SUSPEND command allows the system to interrupt a PROGRAM operation so that data can be read from any block. When the PROGRAM SUSPEND command is issued during a PROGRAM operation, the device suspends the PROGRAM operation within the program suspend latency time and updates the status register bits (see Program/Erase Characteristics).

After the PROGRAM operation has been suspended, the system can read array data from any address. However, data read from program-suspended addresses is not valid.

The PROGRAM SUSPEND command may also be issued during a PROGRAM operation while an erase is suspended. In this case, data may be read from any addresses not in ERASE SUSPEND or PROGRAM SUSPEND. If a read is needed from the extended block area (one-time program area), the user must use the proper command sequences to enter and exit this region.

The system may also issue the AUTO SELECT command sequence when the device is in the program suspend mode. The system can read as many auto select codes as required. When the device exits the auto select mode, the device reverts to the program suspend mode, and is ready for another valid operation.

PROGRAM RESUME Command

After the PROGRAM RESUME command is issued, the device reverts to programming. The controller can determine the status of the PROGRAM operation using the DQ7 or DQ6 status bits, just as in the standard PROGRAM operation.

The system must write the PROGRAM RESUME command, to exit the program suspend mode and to continue the programming operation.

Further issuing of the RESUME command is ignored. Another PROGRAM SUSPEND command can be written after the device has resumed programming.

Fast Program Commands

There are five fast program commands available to improve the programming throughput, by writing several adjacent words or bytes in parallel:

- QUADRUPLE and OCTUPLE BYE PROGRAM, available for x8 operations
- DOUBLE and QUADRUPLE WORD PROGRAM, available for x16 operations
- WRITE TO BUFFER AND PROGRAM

Fast program commands can be suspended and then resumed by issuing a PROGRAM SUSPEND command and a PROGRAM RESUME command, respectively.

To perform some of the fast program commands, V_{PPH} must be applied V_{PP}/WP#. Note that doing so will temporarily unprotect any protected block.

DOUBLE BYTE PROGRAM Command

The DOUBLE BYTE PROGRAM command is used to write a page of two adjacent bytes in parallel. The two bytes must differ only in DO15A-1. Three bus WRITE cycles are necessary to issue the DOUBLE BYTE PROGRAM command:

The first bus cycle sets up the DOUBLE BYTE PROGRAM command; the second bus cycle latches the address and the data of the first byte to be written; and the third bus cycle latches the address and the data of the second byte to be written.

OUADRUPLE BYTE PROGRAM Command

The QUADRUPLE BYTE PROGRAM command is used to write a page of four adjacent bytes in parallel. The four bytes must differ only for addresses A0, DQ15A-1. Five bus write cycles are necessary to issue the QUADRUPLE BYTE PROGRAM command:

The first bus cycle sets up the QUADRUPLE BYTE PROGRAM command; the second bus cycle latches the address and the data of the first byte to be written; the third bus cycle latches the address and the data of the second byte to be written; the fourth bus cycle latches the address and the data of the third byte to be written; and the fifth bus cycle latches the address and the data of the fourth byte to be written and starts the program/ erase controller.

OCTUPLE BYTE PROGRAM Command

This is used to write eight adjacent bytes, in x8 mode, simultaneously. The addresses of the eight bytes must differ only in A1, A0 and DQ15A-1.



12V must be applied to V_{PP} /Wp# prior to issuing an OCTUPLE BYTE PROGRAM command. Care must be taken because applying a 12V voltage to V_{PP} /WP#, because it will temporarily unprotect any protected block.

Nine bus WRITE cycles are necessary to issue the command:

The first bus cycle sets up the command; the second bus cycle latches the address and the data of the first byte to be written; the third bus cycle latches the address and the data of the second byte to be written; the fourth bus cycle latches the address and the data of the third byte to be written, the fifth bus cycle latches the address and the data of the fourth byte to be written; the sixth bus cycle latches the address and the data of the fifth byte to be written; the seventh bus cycle latches the address and the data of the sixth byte to be written; the eighth bus cycle latches the address and the data of the seventh byte to be written; and the ninth bus cycle latches the address and the data of the eighth byte to be written and starts the program/erase controller.

DOUBLE WORD PROGRAM Command

The DOUBLE WORD PROGRAM command is used to write a page of two adjacent words in parallel. The two words must differ only for the address A0.

Three bus WRITE cycles are necessary to issue the DOUBLE WORD PROGRAM command:

The first bus cycle sets up the DOUBLE WORD PROGRAM command; the second bus cycle latches the address and the data of the first word to be written; and the third bus cycle latches the address and the data of the second word to be written and starts the program/erase controller.

After the PROGRAM operation has completed, the memory will return to the read mode, unless an error has occurred. When an error occurs, bus READ operations will continue to output the status register. A READ/RESET command must be issued to reset the error condition and return to read mode.

Note that the fast program commands cannot change a bit set to 0 back to 1. One of the ERASE commands must be used to set all the bits in a block or in the whole memory from 0 to 1.

Typical program times are given in Program/Erase Characteristics.

Note: It is not necessary to raise V_{PP}/WP# to 12V before issuing this command.

QUADRUPLE WORD PROGRAM Command

This is used to write a page of four adjacent words (or 8 adjacent bytes), in x16 mode, simultaneously. The addresses of the four words must differ only in A1 and A0.

12V must be applied to $\rm V_{PP}/WP\#$ prior to issuing a QUADRUPLE BYTE PROGRAM command. Care must be taken because applying a 12V voltage to $\rm V_{PP}/WP\#$, because it will temporarily unprotect any protected block.

Five bus WRITE cycles are necessary to issue the command:

The first bus cycle sets up the command; the second bus cycle latches the address and the data of the first word to be written; the third bus cycle latches the address and the data of the second word to be written; the fourth bus cycle latches the address and the data of the third word to be written; and the fifth bus cycle latches the address and the data of the fourth word to be written and starts the program/erase controller.



UNLOCK BYPASS Command

The UNLOCK BYPASS command is used in conjunction with the UNLOCK BYPASS PROGRAM command to program the memory faster than with the standard PROGRAM commands. When the cycle time to the device is long, considerable time saving can be made by using these commands. Three bus WRITE operations are required to issue the UNLOCK BYPASS command.

After the UNLOCK BYPASS command has been issued, the memory will only accept the UNLOCK BYPASS PROGRAM command and the UNLOCK BYPASS RESET command. The memory can be read as if in read mode.

When V_{PP} is applied to $V_{PP}/WP\#$, the memory automatically enters the unlock bypass mode and the UNLOCK BYPASS PROGRAM command can be issued immediately.

UNLOCK BYPASS PROGRAM Command

The UNLOCK BYPASS command is used in conjunction with the UNLOCK BYPASS PROGRAM command to program the memory. When the cycle time to the device is long, considerable time saving can be made by using these commands. Three bus WRITE operations are required to issue the UNLOCK BYPASS command.

After the UNLOCK BYPASS command has been issued, the memory will only accept the UNLOCK BYPASS PROGRAM command and the UNLOCK BYPASS RESET command. The memory can be read as if in read mode.

The memory offers accelerated PROGRAM operations through $V_{PP}/WP\#$. When the system asserts V_{PP} on $V_{PP}/WP\#$, the memory automatically enters the unlock bypass mode. The system may then write the two-cycle UNLOCK BYPASS PROGRAM command sequence. The memory uses the higher voltage on $V_{PP}/WP\#$ to accelerate the UNLOCK BYPASS PROGRAM operation.

Never raise $V_{PP}/WP\#$ to V_{PP} from any mode except read mode; otherwise, the memory may be left in an indeterminate state.

UNLOCK BYPASS RESET Command

The UNLOCK BYPASS RESET command can be used to return to read/reset mode from unlock bypass mode. Two bus WRITE operations are required to issue the UNLOCK BYPASS RESET command. A READ/RESET command does not exit from unlock bypass mode.

CHIP ERASE Command

The CHIP ERASE command can be used to erase the entire chip. Six bus WRITE operations are required to issue the CHIP ERASE command and start the program/erase controller.

If any blocks are protected, then these are ignored and all the other blocks are erased. If all of the blocks are protected the CHIP ERASE operation appears to start but will terminate within about 100µs, leaving the data unchanged. No error condition is given when protected blocks are ignored.

During the ERASE operation, the memory will ignore all commands, including the ERASE SUSPEND command. It is not possible to issue any command to abort the oper-



ation. All bus READ operations during the CHIP ERASE operation will output the status register on the data I/Os.

After the CHIP ERASE operation has completed, the memory will return to the read mode, unless an error has occurred. When an error occurs, the memory will continue to output the status register. A READ/RESET command must be issued to reset the error condition and return to read mode.

The CHIP ERASE command sets all of the bits in unprotected blocks of the memory to 1. All previous data is lost.

BLOCK ERASE Command

The BLOCK ERASE command can be used to erase a list of one or more blocks. Six bus WRITE operations are required to select the first block in the list. Each additional block in the list can be selected by repeating the sixth bus WRITE operation using the address of the additional block. The BLOCK ERASE operation starts the program/erase controller about 50µs after the last bus WRITE operation. After the program/erase controller starts, it is not possible to select any more blocks. Each additional block must therefore be selected within 50µs of the last block. The 50µs timer restarts when an additional block is selected. The status register can be read after the sixth bus WRITE operation. (See the status register section for details on how to identify whether the program/erase controller has started the BLOCK ERASE operation.)

If any selected blocks are protected, then these are ignored and all the other selected blocks are erased. If all of the selected blocks are protected, the BLOCK ERASE operation appears to start but will terminate within about 100µs, leaving the data unchanged. No error condition is given when protected blocks are ignored.

During the BLOCK ERASE operation, the memory will ignore all commands except the ERASE SUSPEND command. (Typical block erase times are given in the Program/Erase Characteristics.) All bus READ operations during the BLOCK ERASE operation will output the status register on the data I/Os.

After the BLOCK ERASE operation has completed, the memory will return to the read mode, unless an error has occurred. When an error occurs, the memory will continue to output the status register. A READ/RESET command must be issued to reset the error condition and return to read mode.

The BLOCK ERASE command sets all of the bits in the unprotected selected blocks to 1. All previous data in the selected blocks is lost.

ERASE SUSPEND Command

The ERASE SUSPEND command may be used to temporarily suspend a BLOCK ERASE operation and return the memory to read mode. The command requires one bus WRITE operation.

The program/erase controller will suspend within the erase suspend latency time of the ERASE SUSPEND command being issued. After the program/erase controller has stopped, the memory will be set to read mode and the erase will be suspended. If the ERASE SUSPEND command is issued during the period when the memory is waiting for an additional block (before the program/erase controller starts), then the erase is suspended immediately and will start immediately when the ERASE RESUME command is issued. It is not possible to select any further blocks to erase after the ERASE RESUME.



During ERASE SUSPEND, it is possible to read and program cells in blocks that are not being erased; both READ and PROGRAM operations behave as normal on these blocks. If any attempt is made to program in a protected block or in the suspended block, then the PROGRAM command is ignored and the data remains unchanged. The status register is not read and no error condition is given. Reading from blocks that are being erased will output the status register.

It is also possible to issue the AUTO SELECT, READ CFI QUERY, and UNLOCK BYPASS commands during an ERASE SUSPEND. The READ/RESET command must be issued to return the device to read array mode before the RESUME command will be accepted.

ERASE RESUME Command

The ERASE RESUME command must be used to restart the program/erase controller after an erase suspend. The device must be in read array mode before the RESUME command will be accepted. An erase can be suspended and resumed more than once.

ENTER EXTENDED BLOCK Command

The device has an extra 256-byte block (extended block) that can only be accessed using the ENTER EXTENDED BLOCK command. Three bus WRITE cycles are required to issue the ENTER EXTENDED BLOCK command. After the command has been issued, the device enters extended block mode where all bus READ or WRITE operations to the boot block addresses access the extended block. The extended block (with the same address as the boot blocks) cannot be erased, and can be treated as OTP memory. In extended block mode, the boot blocks are not accessible.

The extended block can be protected; however, once protected, the protection cannot be undone.

EXIT EXTENDED BLOCK Command

The EXIT EXTENDED BLOCK command is used to exit from the extended block mode and return the device to read mode. Four bus WRITE operations are required to issue the command.

BLOCK PROTECT and CHIP UNPROTECT Commands

Groups of blocks can be protected against accidental program or erase. (See Memory Organization for the protection groups.) The whole chip can be unprotected to allow the data inside the blocks to be changed.

BLOCK PROTECT Command

Block protection can be used to prevent any operation from modifying the data stored in the Flash. Each block can be protected individually. Once protected, PROGRAM and ERASE operations on the block fail to change the data.

There are three techniques that can be used to control block protection. These are programmer technique, in-system technique, and temporary unprotect. Temporary unprotect is controlled by RST#.

Unlike the command interface of the program/erase controller, the techniques for protecting and unprotecting blocks change between different Flash memory suppliers. Care should be taken when changing drivers for one part to work on another.



Programmer Technique

The programmer technique uses high voltage levels ($V^{\rm ID}$) on some of the bus pins. These cannot be achieved using a standard microprocessor bus; therefore, the technique is recommended only for use in programming equipment.

To protect a block, follow the steps in the following figure. To unprotect the whole chip, it is necessary to protect all of the blocks first, then all blocks can be unprotected at the same time. (See the Programmer Equipment Chip Protect Flowchart.)

The timing on these flowcharts is critical. Care should be taken to ensure that, where a pause is specified, it is followed as closely as possible. Do not abort the procedure before reaching the end. Chip unprotect can take several seconds and a user message should be provided to show that the operation is progressing.



Figure 6: Programmer Equipment Block Protect Flowchart

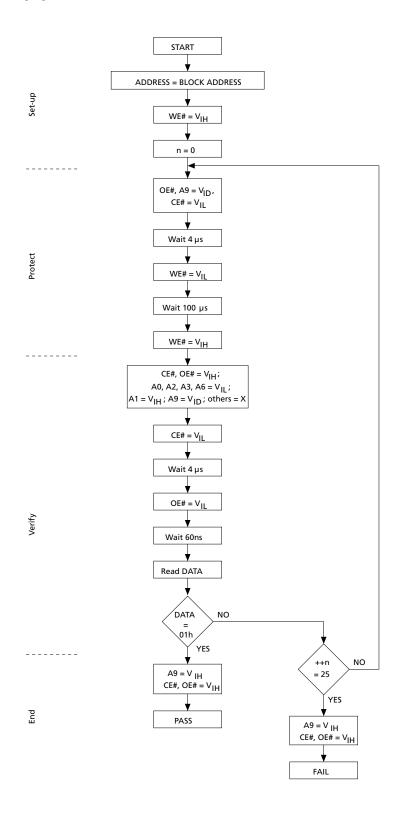




Figure 7: Programmer Equipment Chip Unprotect Flowchart

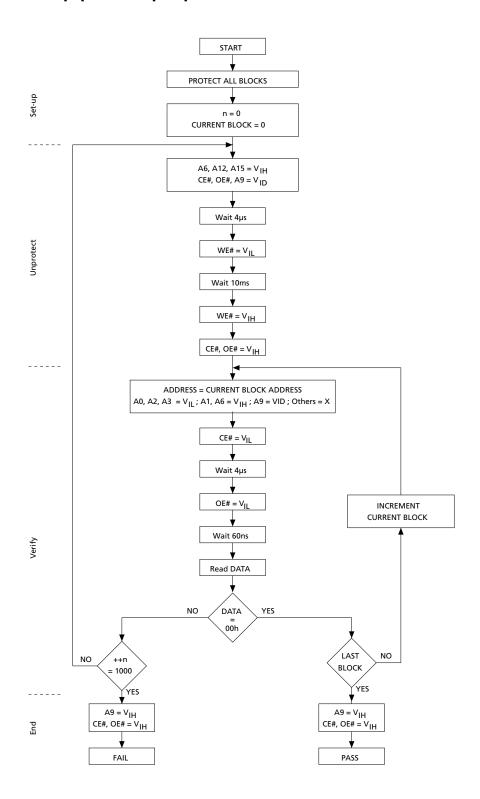




Table 13: Programmer Technique Bus Operations

Notes 1 and 2 apply to entire table

| | | | | Address Inputs | Data I/O |
|-------------------------------|-----------------|-----------------|-----------------|--|-------------------------------|
| Operation | CE# | OE# | WE# | A[MAX:0] | DQ15/A-1, DQ[14:0] |
| BLOCK PROTECT | L | V _{ID} | L pulse | $A9 = V_{ID}$ $A[21:12] block addresses$ $others = X$ | Х |
| CHIP UNPROTECT | V _{ID} | V _{ID} | L pulse | $A9 = V_{ID}$ $A12 = V_{IH}$ $A15 = V_{IH}$ $others = X$ | х |
| BLOCK PROTECTION VERIFY | L | L | V _{IH} | A0, A2, A3 = V_{IL} A1 = V_{IH} A6 = V_{IL} A9 = V_{ID} A[21:12] block addresses others = X | Pass = XX01h Retry = XX00h |
| BLOCK UNPROTECT VERIFY | L | L | V _{IH} | A0, A2, A3 = V_{IL} A1 = V_{IH} A6 = V_{IH} A9 = V_{ID} A[21:12] block addresses others = X | Retry = XX01h Pass = XX00h |

Notes

- 1. Typical glitches of less than 5ns on CE# and WE# are ignored by the device and do not affect bus operations.
- 2. $H = Logic level HIGH (V_{IH}); L = Logic level LOW (V_{II}); X = HIGH or LOW.$

In-System Technique

The in-system technique requires a high-voltage level on RST#. This can be achieved without violating the maximum ratings of the components on the microprocessor bus; therefore, this technique is suitable for use after the Flash has been fitted to the system.

To protect a block, follow the steps in the following figure. To unprotect the whole chip, it is necessary to protect all of the blocks first, then all the blocks can be unprotected at the same time. (See the In-System Equipment Chip Unprotect Flowchart.)

The timing on these flowcharts is critical. Care should be taken to ensure that, where a pause is specified, it is followed as closely as possible. Do not allow the microprocessor to service interrupts that will upset the timing and do not abort the procedure before reaching the end. Chip unprotect can take several seconds and a user message should be provided to show that the operation is progressing.



Figure 8: In-System Equipment Block Protect Flowchart

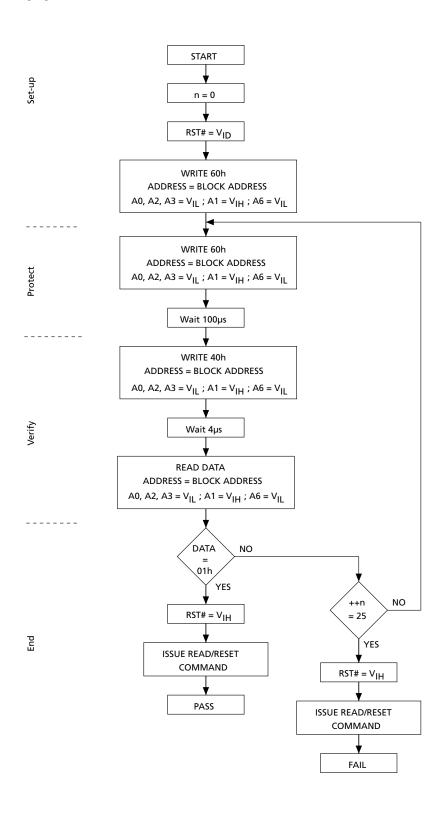




Figure 9: In-System Equipment Chip Protect Flowchart

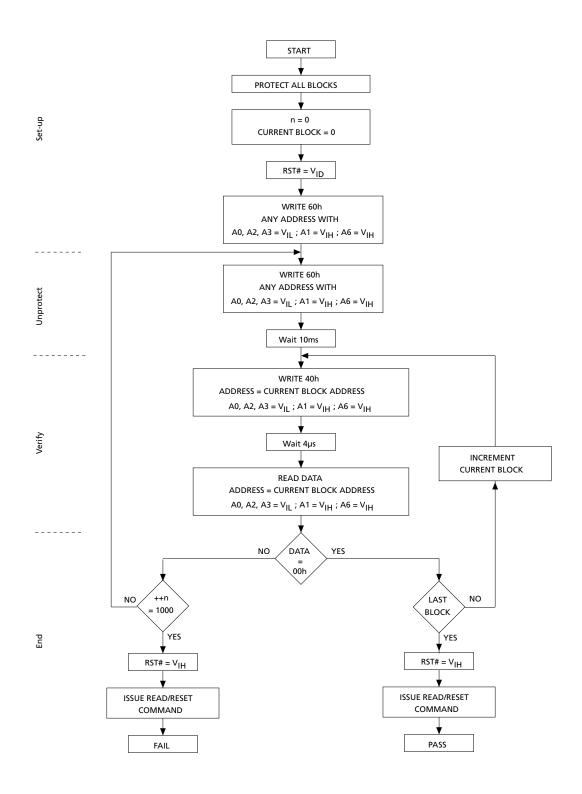




Table 14: Commands - 16-Bit Mode (BYTE# = VIL)

| | | | | | | Bus | WRITE | Operati | ons | | | | |
|---------------------------------|--------|-----------------------|------|------|------|------|-------|---------|----------------------|-----------------------|------|----------------|------|
| | | 1: | st | 2r | nd | 31 | rd | 41 | th | 51 | th | 61 | th |
| Command | Length | Addr | Data | Addr | Data | Addr | Data | Addr | Data | Addr | Data | Addr | Data |
| READ/RESET | 1 | Х | F0 | | | | | | | | | | |
| | 3 | 555 | AA | 2AA | 55 | Х | F0 | | | | | | |
| READ CFI QUERY | 3 | 555 | AA | 2AA | 55 | 555 | 90 | | | | | | |
| PROGRAM | 1 | 55 | 98 | | | | | | | | | | |
| UNLOCK BY- PASS | N + 5 | 555 | AA | 2AA | 55 | BA | 25 | ВА | N ^{on} page | PA ^{on} page | PD | WBL on page | PD |
| UNLOCK BY- PASS PRO- GRAM | 3 | 555 | AA | 2AA | 55 | 555 | F0 | | | | | | |
| UNLOCK BY- PASS RESET | 1 | BA ^{on} page | 29 | | | | | | | | | | |
| CHIP ERASE | 6 | 555 | AA | 2AA | 55 | 555 | 80 | 555 | AA | 2AA | 55 | 555 | 10 |
| BLOCK ERASE | 6+ | 555 | AA | 2AA | 55 | 555 | 80 | 555 | AA | 2AA | 55 | BA | 30 |
| PROGRAM/ ERASE SUS- PEND | 1 | Х | В0 | | | | | | | | | | |
| PROGRAM/ ERASE RESUME | 1 | Х | 30 | | | | | | | | | | |
| ENTER EXTEN- DED BLOCK | 3 | 555 | AA | 2AA | 55 | 555 | 88 | | | | | | |
| EXIT EXTEN- DED BLOCK | 4 | 555 | AA | 2AA | 55 | 555 | 90 | Х | 00 | | | | |

- Notes: 1. X = "Don't Care;" PA = Program address; PD = Program data; BA = Any address in the block. All values in the table are in hexadecimal. The command interface only uses A-1; A0-A10 and DQ0-DQ7 to verify the commands; A11-A20, DQ8-DQ14 and DQ15 are "Don't Care." DQ15A-1 is A-1 when BYTE# is $V_{\rm IL}$ or DQ15 when BYTE# is $V_{\rm IH}$.
 - 2. The maximum number of cycles in the command sequence is 36. N + 1 is the number of words to be programmed during the WRITE TO BUFFER AND PROGRAM operation.
 - 3. Each buffer has the same A4-A22 addresses. A0-A3 are used to select a word within the N + 1 word page.
 - 4. The 6th cycle has to be issued N time. WBL scans the word inside the page.
 - 5. BA must be identical to the address loaded during the WRITE TO BUFFER AND PRO-GRAM 3rd and 4th cycles.



Table 15: Commands – 8-Bit Mode (BYTE# = V_{IL})

| | | | | | | Bus | WRITE | Operati | ions | | | | |
|---------------------------------|--------|------|------|------|------|------|-------|---------|------|------|------|------|------------------------|
| | | 1: | st | 21 | nd | 31 | rd | 41 | th | 51 | th | 6 | th |
| Command | Length | Addr | Data | Addr | Data | Addr | Data | Addr | Data | Addr | Data | Addr | Data |
| READ/RESET | 1 | Х | F0 | | | | | | | | | | |
| | 3 | AAA | AA | 555 | 55 | Х | F0 | | | | | | |
| AUTO SELECT | 3 | AAA | AA | 555 | 55 | AAA | 90 | | | | | | |
| READ CFI QUERY | 1 | AA | 98 | | | | | | | | | | |
| PROGRAM | 4 | AAA | AA | 555 | 55 | AAA | A0 | PA | PD | | | | |
| DOUBLE BYTE PROGRAM | 3 | AAA | 50 | PA0 | PD0 | PA1 | PD1 | | | | | | |
| QUADRUPLE BYTE PRO- GRAM | 5 | AAA | 56 | PA0 | PD0 | PA1 | PD1 | PA2 | PD2 | PA3 | PD3 | | |
| OCTUPLE BYTE PROGRAM | 9 | AAA | 8B | PA0 | PD0 | PA1 | PD1 | PA2 | PD2 | PA3 | PD3 | PA4 | PD4 ^{on} page |
| UNLOCK BY- PASS | 3 | AAA | AA | 555 | 55 | AAA | 20 | | | | | | |
| UNLOCK BY- PASS PRO- GRAM | 2 | Х | A0 | PA | PD | | | | | | | | |
| UNLOCK BY- PASS RESET | 2 | Х | 90 | Х | 00 | | | | | | | | |
| CHIP ERASE | 6 | AAA | AA | 555 | 55 | AAA | 80 | AAA | AA | 555 | 55 | AAA | 10 |
| BLOCK ERASE | 6+ | AAA | AA | 555 | 55 | AAA | 80 | AAA | AA | 555 | 55 | ВА | 30 |
| PROGRAM/ ERASE SUS- PEND | 1 | Х | В0 | | | | | | | | | | |
| PROGRAM/ ERASE RE- SUME | 1 | Х | 30 | | | | | | | | | | |
| ENTER EXTEN- DED BLOCK | 3 | AAA | AA | 555 | 55 | AAA | 88 | | | | | | |
| EXIT EXTEN- DED BLOCK | 4 | AAA | AA | 555 | 55 | AAA | 90 | Х | 00 | | | | |

Notes:

- 1. $X = "Don't Care;" PA = Program address; PD = Program data; BA = Any address in the block. All values in the table are in hexadecimal. The command interface only uses A-1, A0–A10, and DQ0–DQ7 to verify the commands; A11–A20, DQ8–DQ14, and DQ15 are "Don't Care." DQ15A-1 is A-1 when BYTE# is <math>V_{IL}$ or DQ15 when BYTE# is V_{IH} .
- 2. The maximum number of cycles in the command sequence is 36. N + 1 is the number of words to be programmed during the WRITE TO BUFFER AND PROGRAM operation.
- 3. Each buffer has the same A4–A22 addresses. A0–A3 are used to select a word within the N + 1 word page.

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- 4. The 6th cycle has to be issued N time. WBL scans the word inside the page.
- BA must be identical to the address loaded during the WRITE TO BUFFER AND PRO-GRAM 3rd and 4th cycles.

Common Flash Interface

The common Flash interface (CFI) is a JEDEC-approved, standardized data structure that can be read from the Flash memory device. It allows a system's software to query the device to determine various electrical and timing parameters, density information, and functions supported by the memory. The system can interface easily with the device, enabling the software to upgrade itself when necessary.

When the READ CFI command is issued, the device enters CFI query mode and the data structure is read from memory. The following tables show the addresses (A-1, A[7:0]) used to retrieve the data. The query data is always presented on the lowest order data outputs (DQ[7:0]), and the other data outputs (DQ[15:8]) are set to 0.

Table 16: Query Structure Overview

Note 1 applies to the entire table

| Add | ress | | |
|-----|------|---|---|
| x16 | х8 | Subsection Name | Description |
| 10h | 20h | CFI query identification string | Command set ID and algorithm data offset |
| 1Bh | 36h | System interface information | Device timing and voltage information |
| 27h | 4Eh | Device geometry definition | Flash device layout |
| 40h | 80h | Primary algorithm-specific extended query table | Additional information specific to the primary algorithm (optional) |
| 61h | C2h | Security code area | 64-bit unique device number |

Note: 1. Query data are always presented on the lowest order data outputs (DQ[7:0]). DQ[15:8] are set to 0.

Table 17: CFI Query Identification String

Note 1 applies to the entire table

| Add | ress | | | |
|-----|------|-------|---|-------------|
| x16 | ж8 | Data | Description | Value |
| 10h | 20h | 0051h | Query unique ASCII string "QRY" | "Q" |
| 11h | 22h | 0052h | | "R" |
| 12h | 24h | 0059h | | "Y" |
| 13h | 26h | 0002h | Primary algorithm command set and control interface ID code 16-bit ID | AMD compat- |
| 14h | 28h | 0000h | code defining a specific algorithm | ible |
| 15h | 2Ah | 0040h | Address for primary algorithm extended query table (see the Primary Algo- | P = 40h |
| 16h | 2Ch | 0000h | rithm-Specific Extended Query Table) | |
| 17h | 2Eh | 0000h | Alternate vendor command set and control interface ID code second ven- | _ |
| 18h | 30h | 0000h | dor-specified algorithm supported | |



Table 17: CFI Query Identification String (Continued)

Note 1 applies to the entire table

| Add | lress | | | |
|-----|-------|-------|--|-------|
| x16 | х8 | Data | Description | Value |
| 19h | 32h | 0000h | Address for alternate algorithm extended query table | _ |
| 1Ah | 34h | 0000h | | |

Note: 1. Query data are always presented on the lowest order data outputs (DQ[7:0]). DQ[15:8] are set to 0.

Table 18: CFI Query System Interface Information

Note 1 applies to the entire table

| Add | Iress | | | |
|-----|-------|-------|---|-------|
| x16 | х8 | Data | Description | Value |
| 1Bh | 36h | 0027h | V _{CC} logic supply minimum program/erase voltage Bits[7:4] BCD value in volts Bits[3:0] BCD value in 100mV | 2.7V |
| 1Ch | 38h | 0036h | V _{CC} logic supply maximum program/erase voltage Bits[7:4] BCD value in volts Bits[3:0] BCD value in 100mV | 3.6V |
| 1Dh | 3Ah | 00B5h | V _{PPH} (programming) supply minimum program/erase voltage Bits[7:4] hex value in volts Bits[3:0] BCD value in 100mV | 11.5V |
| 1Eh | 3Ch | 00C5h | V _{PPH} (programming) supply maximum program/erase voltage Bits[7:4] hex value in volts Bits[3:0] BCD value in 100mV | 12.5V |
| 1Fh | 3Eh | 0004h | Typical timeout for single byte/word program = 2 ⁿ µs | 16µs |
| 20h | 40h | 0000h | Typical timeout for maximum size buffer program = 2 ⁿ µs | NA |
| 21h | 42h | 000Ah | Typical timeout per individual block erase = 2 ⁿ ms | 1s |
| 22h | 44h | 0000h | Typical timeout for full chip erase = 2 ⁿ ms | NA |
| 23h | 46h | 0004h | Maximum timeout for byte/word program = 2 ⁿ times typical | 256µs |
| 24h | 48h | 0004h | Maximum timeout for buffer program = 2 ⁿ times typical | 200µs |
| 25h | 4Ah | 0003h | Maximum timeout per individual block erase = 2 ⁿ times typical | 8s |
| 26h | 4Ch | 0000h | Maximum timeout for chip erase = 2 ⁿ times typical | NA |

Note: 1. The values in this table are valid for both packages.

Table 19: Device Geometry Definition

| Address | | | | |
|------------|------------|----------------|---|-------------------------|
| x16 | х8 | Data | Description | Value |
| 27h | 4Eh | 0017h | Device size = 2 ⁿ in number of bytes | 8MB |
| 28h 29h | 50h 52h | 0002h 0000h | Flash device interface code description | x8, x16 asynchronous |



Table 19: Device Geometry Definition (Continued)

| Address | | | | |
|-------------|---------------|----------|--|-------|
| x16 | х8 | Data | Description | Value |
| 2Ah | 54h | 0004h | Maximum number of bytes in multi-byte program or page = | 16B |
| 2Bh | 56h | 0000h | 2 ⁿ | |
| 2Ch | 58h | 0002h | Number of erase block regions. It specifies the number of | 2 |
| | | | regions containing contiguous erase blocks of the same size. | |
| Erase block | region 1 info | ormation | | |
| 2Dh | 5Ah | 0007h | Number of identical-size erase blocks = 00FFh + 1 | 8 |
| 2Eh | 5Ch | 0000h | | |
| 2Fh | 5Eh | 0020h | Block size = 0200h × 256 bytes | 8KB |
| 30h | 60h | 000h | | |
| Erase block | region 2 info | ormation | | |
| 31h | 62h | 007Eh | Number of erase blocks of identical size = 007Eh + 1 | 127 |
| 32h | 64h | 0000h | | |
| 33h | 66h | 0000h | Block size = 0100h x 256 byte | 64KB |
| 34h | 68h | 0000h | | |
| Erase block | region 3 info | ormation | | |
| 35h | 6Ah | 0000h | Number of erase blocks of identical size = 007Fh+1 | 0 |
| 36h | 6Ch | 0000h | | |
| 37h | 6Eh | 0000h | Block size = 0000h x 256 byte | 0 |
| 38h | 70h | 0000h | | |
| Erase blocl | region 4 info | ormation | | |
| 39h | 72h | 0000h | Number of erase blocks of identical size = 007Fh + 1 | 0 |
| 3Ah | 74h | 0000h | | |
| 3Bh | 76h | 0000h | Block size in region 4 = 0000h x 256 byte | 0 |
| 3Ch | 78h | 0000h | | |

Note: 1. Bottom boot device, erase block region address locations: region 1 is address 000000h to 007FFFh; region 2 is address 008000h to 3FFFFFh. Top boot device, erase block region address locations: region 1 is address 000000h to 3F7FFFh; region 2 is address 3F8000h to 3FFFFFh.

Table 20: Primary Algorithm-Specific Extended Query Table

Note 1 applies to the entire table

| Add | Address | | | |
|-----|---------|-------|--|-------|
| x16 | х8 | Data | Description | Value |
| 40h | 80h | 0050h | Primary algorithm extended query table unique ASCII string "PRI" | "P" |
| 41h | 82h | 0052h | | "R" |
| 42h | 84h | 0049h | | " " |
| 43h | 86h | 0031h | Major version number, ASCII | "1" |
| 44h | 88h | 0033h | Minor version number, ASCII | "3" |



Table 20: Primary Algorithm-Specific Extended Query Table (Continued)

Note 1 applies to the entire table

| Add | lress | | | |
|-----|-------|-------|--|--|
| x16 | х8 | Data | Description | Value |
| 45h | 8Ah | 0000h | Address sensitive unlock (bits[1:0]): 00 = Required 01 = Not required Silicon revision number (bits[7:2]) | Yes 65nm |
| 46h | 8Ch | 0002h | Erase suspend: 00 = Not supported 01 = Read only 02 = Read and write | 2 |
| 47h | 8Eh | 0004h | Block protection: 00 = Not supported x = Number of blocks per group | 4 |
| 48h | 90h | 0001h | Temporary block unprotect: 00 = Not supported 01 = Supported | Yes |
| 49h | 92h | 0004h | Block protect/unprotect: 04=M29W640F | 04 |
| 4Ah | 94h | 0000h | Simultaneous operations: 00h = Not supported | No |
| 4Bh | 96h | 0000h | Burst mode: 00 = Not supported 01 = Supported | No |
| 4Ch | 98h | 0001h | Page mode: 00 = Not supported 01 = 4-word page 02 = 8-word page | Yes |
| 4Dh | 9Ah | 00B5h | V _{PPH} supply minimum program/erase voltage: Bits[7:4] hex value in volts Bits[3:0] BCD value in 100mV | 11.5V |
| 4Eh | 9Ch | 00C5h | V _{PPH} supply maximum program/erase voltage: Bits[7:4] hex value in volts Bits[3:0] BCD value in 100mV | 12.5V |
| 4Fh | 9Eh | 00xxh | Top/bottom boot block flag: 02h = Bottom boot device 03h = Top boot device | Uniform + V _{PP} /WP# protect- ing highest or lowest block |
| 50h | A0h | 0001h | Program suspend: 00 = Not supported 01 = Supported | 01 |

Note: 1. The values in this table are valid for both packages.



Table 21: Security Code Area

| Add | ress | | |
|-----|-----------|------|-----------------------------|
| x16 | x8 | Data | Description |
| 61h | C3h, C2h | XXXX | 64-bit unique device number |
| 62h | C5h, C4h | XXXX | |
| 63h | C7h, C6h | XXXX | |
| 64h | C9h, C8h | XXXX | |

Absolute Ratings and Operating Conditions

Stresses greater than those listed may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at these or any other conditions outside those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may adversely affect reliability.

Table 22: Absolute Maximum/Minimum Ratings

| Parameter | Symbol | Min | Max | Unit | Notes |
|------------------------|-------------------|------|-----------------------|------|-------|
| Temperature under bias | T _{BIAS} | -50 | 125 | °C | |
| Storage temperature | T _{STG} | -65 | 150 | °C | |
| Input/output voltage | V _{IO} | -0.6 | V _{CC} + 0.6 | V | 1, 2 |
| Supply voltage | V _{CC} | -0.6 | 4 | V | |
| Program voltage | V _{PP} | -0.6 | 13.5 | V | |
| Identification voltage | V _{ID} | -0.6 | 13.5 | V | |

Notes:

- 1. During signal transitions, minimum voltage may undershoot to –2V for periods less than 20ns
- 2. During signal transitions, maximum voltage may overshoot to V_{CC} + 2V for periods less than 20ns.

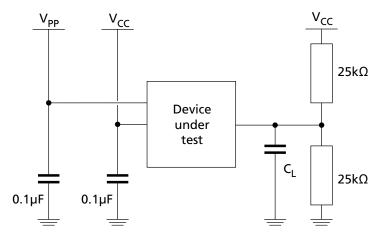
Table 23: Operating Conditions

| Parameter | Symbol | M29W | Unit | |
|-------------------------------|-----------------|---------|------|----|
| | | Min | Max | |
| Supply voltage | V _{CC} | 2.7 3.6 | | V |
| Ambient operating temperature | T _A | -40 85 | | °C |
| Load capacitance | C _L | 3 | pF | |
| Input rise and fall times | _ | - 10 | | ns |
| Input pulse voltages | _ | 0 to | V | |
| I/O timing reference voltages | _ | Vo | V | |

Note: 1. 85°C = industrial part; 125°C = automotive grade part.



Figure 10: AC Measurement Load Circuit



Note: 1. C_L includes jig capacitance.

Figure 11: AC Measurement I/O Waveform

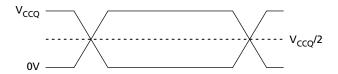


Table 24: Input/Output Capacitance

| Parameter | Symbol | Test Condition | Min | Max | Unit |
|--------------------|------------------|----------------|-----|-----|------|
| Input capacitance | C _{IN} | $V_{IN} = 0V$ | - | 6 | pF |
| Output capacitance | C _{OUT} | $V_{OUT} = 0V$ | - | 12 | pF |

Note: 1. Sampled only, not 100% tested.



DC Characteristics

Table 25: DC Current Characteristics

| Parameter | Symbol | Conditions | Тур | Max | Unit | Notes |
|---|------------------|--|-----|-----|------|-------|
| Input leakage current | ILI | $0V \le V_{IN} \le V_{CC}$ | _ | ±1 | μΑ | |
| Output leakage current | I _{LO} | $0V \le V_{OUT} \le V_{CC}$ | _ | ±1 | μΑ | |
| Read current | I _{CC1} | $CE\# = V_{IL}, OE\# = V_{IH},$ f = 6 MHz | | 10 | mA | 1 |
| Standby current | I _{CC2} | $CE# = V_{CC} \pm 0.2V$ $RP# = V_{CC} \pm 0.2V$ | | 100 | μΑ | 2 |
| Program/erase current | I _{CC3} | Program/erase controller active: $V_{PP}/WP\# = V_{IL}$ or V_{IH} ; $V_{PP}/WP\# = V_{PP}$ | _ | 20 | mA | 1, 3 |
| Current for V _{PP} /WP# program acceleration | I _{PP} | V _{CC} = 2.7V ±10% | _ | 15 | mA | |

- Notes: 1. In dual operations, the supply current will be the sum of I_{CC1} (READ operation) and I_{CC3} (PROGRAM/ERASE operation).
 - 2. When the bus is inactive for 300ns or more, the memory enters automatic standby.
 - 3. Sampled only; not 100% tested.

Table 26: DC Voltage Characteristics

| Parameter | Symbol | Conditions | Min | Max | Unit |
|---|------------------|-----------------------------|-----------------------|-----------------------|------|
| Input LOW voltage | V _{IL} | - | -0.5 | 0.8 | V |
| Input HIGH voltage | V _{IH} | - | 0.7 V _{CCQ} | V _{CC} + 0.3 | V |
| Voltage for V _{PP} /WP# program acceleration | V_{PP} | V _{CC} = 2.7V ±10% | 11.5 | 12.5 | V |
| Output LOW voltage | V _{OL} | I _{OL} = 1.8mA | - | 0.45 | V |
| Output HIGH voltage | V _{OH} | I _{OH} = -100μA | V _{CC} - 0.4 | - | V |
| Identification voltage | V _{ID} | - | 11.5 | 12.5 | V |
| Program/erase lockout supply voltage | V _{LKO} | - | 1.8 | 2.3 | V |



Read AC Characteristics

Table 27: Read AC Characteristics

| | Symbol | | | | 60 | | 70 | | |
|--|-------------------|---|--|-----|-----|-----|-----|------|-------|
| Parameter | Legacy | JEDEC | Condition | Min | Max | Min | Max | Unit | Notes |
| Address valid to next address valid | ^t RC | ^t AVAV | CE# = V _{IL} , OE# = V _{IL} | 60 | - | 70 | - | ns | |
| Address valid to output valid | ^t ACC | ^t AVQV | CE# = V _{IL} , OE# = V _{IL} | - | 60 | - | 70 | ns | |
| Address valid to output valid (page) | ^t PAGE | ^t AVQV1 | CE# = V _{IL} , OE# = V _{IL} | - | 25 | - | 25 | ns | |
| CE# LOW to output transition | ^t LZ | ^t ELQX | OE# = V _{IL} | 0 | _ | 0 | _ | ns | 1 |
| CE# LOW to output valid | ^t E | ^t ELQV | OE# = V _{IL} | _ | 60 | _ | 70 | ns | |
| OE# LOW to output transition | ^t OLZ | ^t GLQX | CE# = V _{IL} | 0 | _ | 0 | _ | ns | 1 |
| OE# LOW to output valid | ^t OE | ^t GLQV | CE# = V _{IL} | _ | 25 | _ | 25 | ns | |
| CE# HIGH to output High-Z | ^t HZ | tEHQZ | OE# = V _{IL} | _ | 25 | _ | 25 | ns | 1 |
| OE# HIGH to output High-Z | ^t DF | ^t GHQZ | CE# = V _{IL} | _ | 25 | _ | 25 | ns | 1 |
| CE#, OE#, or address transition to output transition | ^t OH | ^t EHQX, ^t GHQX, ^t AXQX | _ | 0 | - | 0 | - | ns | |
| CE# to BYTE# LOW | ^t ELFL | ^t ELBL | _ | _ | 5 | _ | 5 | ns | |
| CE# to BYTE# HIGH | ^t ELFH | ^t ELBH | _ | _ | 5 | - | 5 | ns | |
| BYTE# LOW to output High-Z | ^t FLQZ | ^t BLQZ | _ | _ | 25 | _ | 25 | ns | |
| BYTE# HIGH to output valid | ^t FHQV | ^t BHQV | _ | _ | 30 | - | 30 | ns | |

Note: 1. Sampled only; not 100% tested.



Figure 12: Random AC Timing

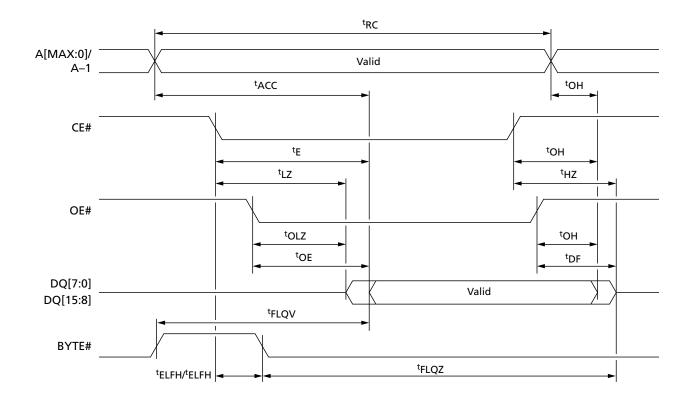
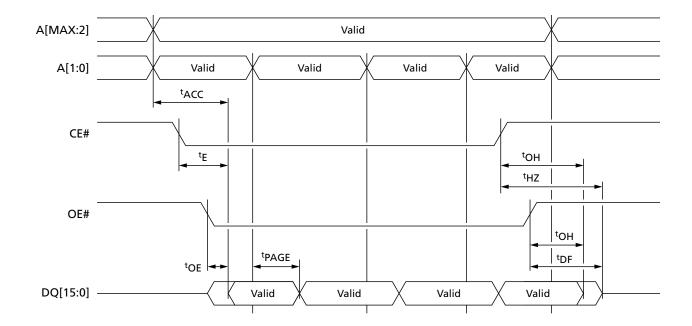




Figure 13: Page Read AC Timing





Write AC Characteristics

Table 28: WE#-Controlled Write AC Characteristics

| | Symbol | | 60 | | 70 | | | |
|--------------------------------------|-------------------|-------------------|-----|-----|-----|-----|------|-------|
| Parameter | Legacy | JEDEC | Min | Max | Min | Max | Unit | Notes |
| Address valid to next address valid | tWC | ^t AVAV | 60 | _ | 70 | - | ns | |
| CE# LOW to WE# LOW | ^t CS | ^t ELWL | 0 | _ | 0 | - | ns | |
| WE# LOW to WE# HIGH | ^t WP | ^t WLWH | 45 | _ | 45 | - | ns | |
| Input valid to WE# HIGH | ^t DS | ^t DVWH | 45 | _ | 45 | - | ns | |
| WE# HIGH to input transition | ^t DH | tWHDX | 0 | _ | 0 | - | ns | |
| WE# HIGH to CE# HIGH | ^t CH | ^t WHEH | 0 | _ | 0 | - | ns | |
| WE# HIGH to WE# LOW | ^t WPH | ^t WHWL | 30 | _ | 30 | - | ns | |
| Address valid to WE# LOW | ^t AS | ^t AVWL | 0 | _ | 0 | - | ns | |
| WE# LOW to address transition | ^t AH | tWLAX | 45 | _ | 45 | - | ns | |
| OE# HIGH to WE# LOW | _ | ^t GHWL | 0 | _ | 0 | - | ns | |
| WE# HIGH to OE# LOW | ^t OEH | ^t WHGL | 0 | _ | 0 | - | ns | |
| Program/erase valid to RY/BY# LOW | ^t BUSY | tWHRL | - | 30 | - | 30 | ns | 1 |
| V _{CC} HIGH to CE# LOW | tVCS | tVCHEL | 50 | - | 50 | - | μs | |

Note: 1. Sampled only; not 100% tested.



Figure 14: WE#-Controlled AC Timing

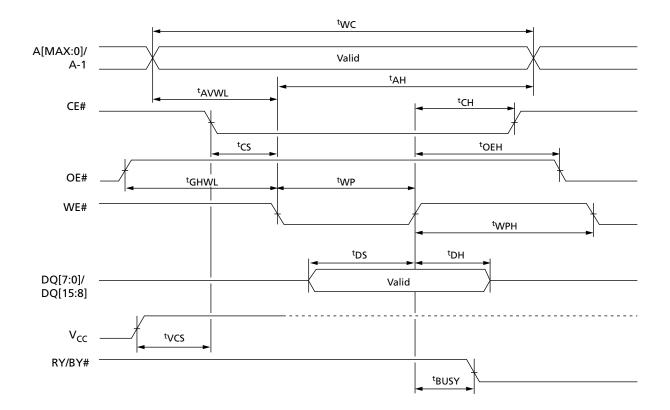




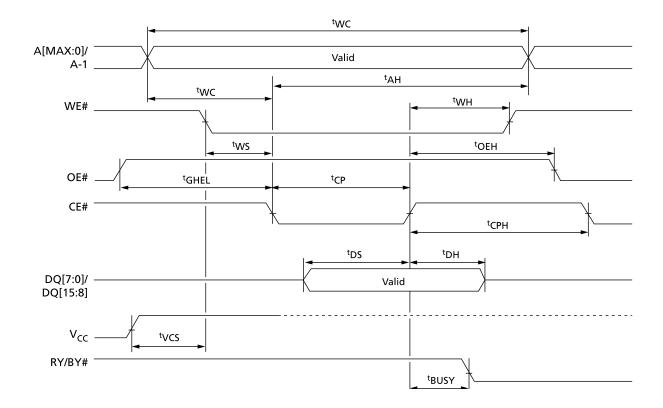
Table 29: CE#-Controlled Write AC Characteristics

| | Symbol | | 6 | 60 | 70 | | | |
|-------------------------------------|-------------------|-------------------|-----|-----------|-----|-----|------|-------|
| Parameter | Legacy | JEDEC | Min | Max | Min | Max | Unit | Notes |
| Address valid to next address valid | tWC | ^t AVAV | 60 | _ | 70 | - | ns | |
| WE# LOW to CE# LOW | tWS | tWLEL | 0 | _ | 0 | - | ns | |
| CE# LOW to CE# HIGH | ^t CP | ^t ELEH | 45 | _ | 45 | - | ns | |
| Input valid to CE# HIGH | ^t DS | ^t DVEH | 45 | _ | 45 | - | ns | |
| CE# HIGH to input transition | ^t DH | ^t EHDX | 0 | _ | 0 | - | ns | |
| CE# HIGH to WE# HIGH | tWH | ^t EHWH | 0 | _ | 0 | - | ns | |
| CE# HIGH to CE# LOW | ^t CPH | ^t EHEL | 30 | _ | 30 | - | ns | |
| Address valid to CE# LOW | ^t AS | ^t AVEL | 0 | _ | 0 | _ | ns | |
| CE# LOW to address transition | ^t AH | ^t ELAX | 45 | _ | 45 | - | ns | |
| OE# HIGH to CE# LOW | - | ^t GHEL | 0 | _ | 0 | _ | ns | |
| CE# HIGH to OE# LOW | ^t OEH | ^t EHGL | 0 | _ | 0 | _ | ns | |
| Program/erase valid to RY/BY# LOW | ^t BUSY | ^t EHRL | _ | 30 | _ | 30 | ns | 1 |
| V _{CC} HIGH to WE# LOW | tVCS | tVCHWL | 50 | _ | 50 | - | ns | |

Note: 1. Sampled only; not 100% tested.



Figure 15: CE#-Controlled AC Timing





Program/Erase Characteristics

Table 30: Program/Erase Times and Endurance Cycles

Notes 1 and 2 apply to the entire table

| Parameter | Min | Тур | Max | Unit | Notes |
|--|---------|-----|-----|--------|-------|
| Chip erase | _ | 80 | 400 | S | 3 |
| Block erase (64KB) | _ | 0.8 | 6 | S | 4 |
| Erase suspend latency time | _ | _ | 50 | μs | 4 |
| Program (byte or word) | _ | 10 | 200 | μs | 3 |
| Double byte | _ | 10 | 200 | μs | |
| Double word /quadruple byte program | | 10 | 200 | μs | 3 |
| Quadruple word/octuple byte program | | 10 | 200 | μs | 3 |
| Chip program (byte by byte) | _ | 80 | 400 | S | 3 |
| Chip program (word by word) | _ | 40 | 200 | S | 3 |
| Chip program (double word/quadruple byte program) | - | 20 | 100 | S | 3 |
| Chip program (quadruple word/octuple byte program) | - | 10 | 50 | S | 3 |
| Program suspend latency time | _ | _ | 4 | μs | |
| PROGRAM/ERASE cycles (per block) | 100,000 | _ | _ | cycles | |
| Data retention | 20 | _ | _ | years | |

- Notes: 1. Typical values measured at room temperature and nominal voltages.
 - 2. Sampled, but not 100% tested.
 - 3. Maximum value measured at worst case conditions for both temperature and V_{CC} after 100,000 PROGRAM/ERASE cycles.
 - 4. Maximum value measured at worst case conditions for both temperature and V_{CC}.



Reset Characteristics

Table 31: Reset/Block Temporary Unprotect AC Characteristics

| | | Syn | M29W640FT/B | | | | |
|---|-----|--------------------|---|-----|-----|------|-------|
| Condition/Parameter | | Legacy | JEDEC | 60 | 70 | Unit | Notes |
| RST# HIGH to WE# LOW, CE# LOW, OE# LOW | Min | ^t RH | ^t PHWL ^t PHEL ^t PHGL | 50 | 50 | ns | 1 |
| RY/BY# HIGH to WE# LOW, CE# LOW, OE# LOW | Min | ^t RB | ^t RHWL ^t RHEL ^t RHGL | 0 | 0 | ns | 1 |
| RST# pulse width | Min | ^t RP | ^t PLPX | 500 | 500 | ns | |
| RST# LOW to read mode | Max | ^t READY | ^t PLYH | 50 | 50 | μs | 1 |
| RST# rise time to V _{ID} | Min | tVIDR | ^t PHPHH | 500 | 500 | ns | 1 |
| V _{PP} rise and fall time | | ^t VHVPP | | 250 | 250 | ns | 1 |

Note: 1. Sampled only; not 100% tested.

Figure 16: Reset/block Temporary Unprotect AC Waveforms

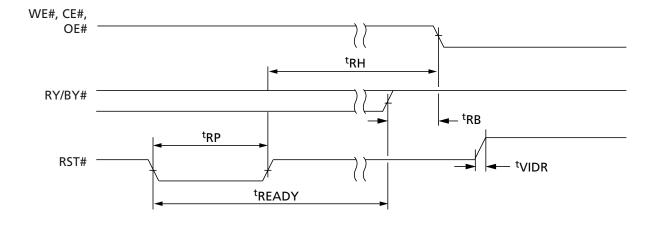
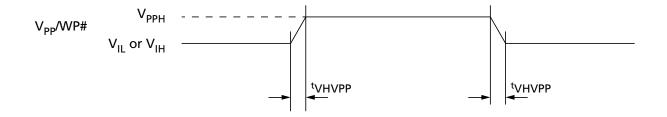


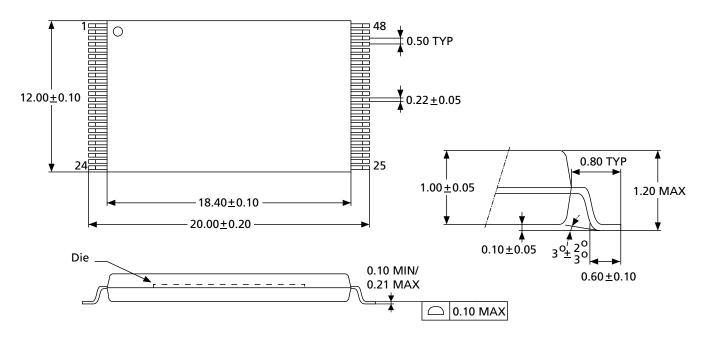
Figure 17: Accelerated Program Timing Waveforms





Package Dimensions

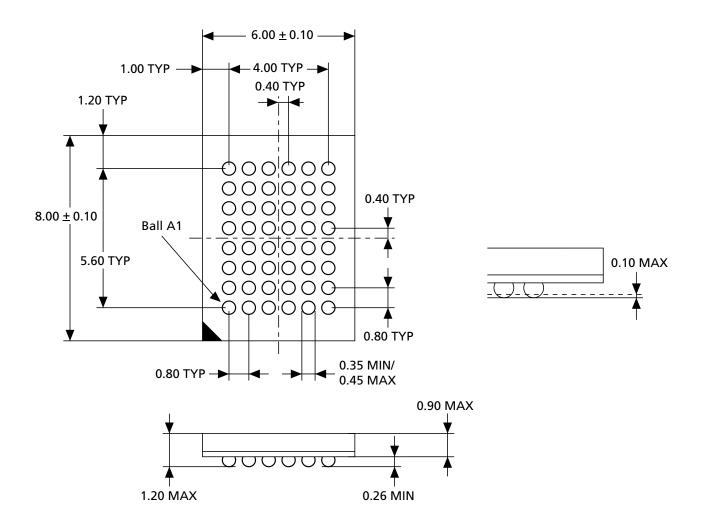
Figure 18: 48-Pin TSOP - 12mm x 20mm



Note: 1. All dimensions are in millimeters.



Figure 19: 48-Ball TFBGA - 6mm x 8mm



Note: 1. All dimensions are in millimeters.





Revision History

Rev. A - 07/13

· Initial Micron brand release

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This data sheet contains minimum and maximum limits specified over the power supply and temperature range set forth herein. Although considered final, these specifications are subject to change, as further product development and data characterization sometimes occur.